Operational Amplifier, Rail-to-Rail Output, 3 MHz BW

TLV271, TLV272, NCV272, TLV274, NCV274

The TLV/NCV27x operational amplifiers provide rail–to–rail output operation. The output can swing within 320 mV to the positive rail and 50 mV to the negative rail. This rail–to–rail operation enables the user to make optimal use of the entire supply voltage range while taking advantage of 3 MHz bandwidth. The opamp can operate on supply voltage as low as 2.7 V over the temperature range of –40°C to 125° C. The high bandwidth provides a slew rate of 2.4 V/µs while only consuming 550 µA of quiescent current. Likewise the opamp can run on a supply voltage as high as 16 V (single) and 36 V (dual quad) making it ideal for a broad range of battery–operated applications. Since this is a CMOS device it has high input impedance and low bias currents making it ideal for interfacing to a wide variety of signal sensors. In addition it comes in a variety of compact packages with different pinout styles allowing for use in high–density PCB's.

Features

- Rail-To-Rail Output
- Wide Bandwidth: 3 MHz
- High Slew Rate: 2.4 V/µs
- Wide Power-Supply Range: 2.7 V to 16 V (TLV271), 36 V (TLV/NCV272/274)
- Low Supply Current: 550 μA
- Low Input Bias Current: 45 pA
- Wide Temperature Range: -40°C to 125°C
- TSOP-5, Micro-8, SOIC-8, SOIC-14, TSSOP-14 Packages
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Notebook Computers
- Portable Instruments
- Signal Conditioning
- Automotive
- Power Supplies
- Current Sensing



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TSOP-5 CASE 483



Micro8 CASE 846A



SOIC-8 CASE 751



SOIC-14 NB CASE 751A



TSSOP-14 CASE 948G

DEVICE MARKING INFORMATION

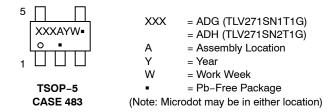
See general marking information in the device marking section on page 2 of this data sheet.

ORDERING INFORMATION

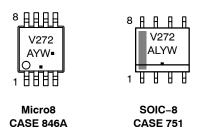
See detailed ordering and shipping information on page 3 of this data sheet.

MARKING DIAGRAMS

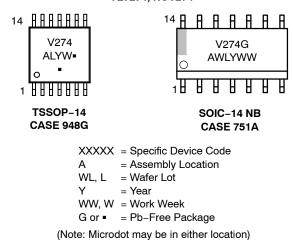
Single Channel Configuration TLV271



Dual Channel Configuration TLV272, NCV272

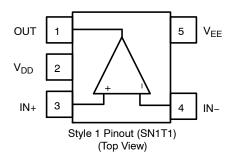


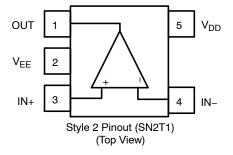
Quad Channel Configuration TLV274, NCV274



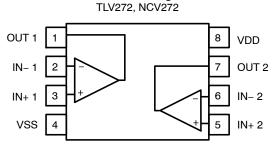
PIN CONNECTIONS

Single Channel Configuration TLV271

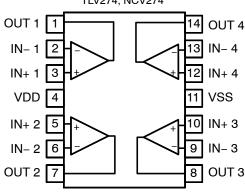




Dual Channel Configuration



Quadruple Channel Configuration TLV274, NCV274



ORDERING INFORMATION

Device	Configuration	Automotive	Marking	Package	Shipping [†]
TLV271SN1T1G (Style 1 Pinout)	0:2212		ADG	T00D 5	3000 / Tape and Reel
TLV271SN2T1G (Style 2 Pinout)	- Single		ADH	TSOP-5	3000 / Tape and Reel
TLV272DR2G	No V272 SOIC-8		2500 / Tape and Reel		
TLV272DMR2G	- Dual		V272	Micro-8/MSOP-8	4000 / Tape and Reel
TLV274DR2G	Overd		V274	SOIC-14	2500 / Tape and Reel
TLV274DTBR2G	- Quad		V274	TSSOP-14	2500 / Tape and Reel
NCV272DR2G*	Durel		V272	SOIC-8	2500 / Tape and Reel
NCV272DMR2G*	- Dual	\/a	V272	Micro-8/MSOP-8	4000 / Tape and Reel
NCV274DR2G*	Ouad	Yes	V274	SOIC-14	2500 / Tape and Reel
NCV274DTBR2G*	Quad		V274	TSSOP-14	2500 / Tape and Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable.

MAXIMUM RATINGS

Symbol	Rating		Value	Unit
V_{DD}	Supply Voltage (Note 1)	TLV271 TLV/NCV272/274	16.5 36	V V
V _{ID}	Input Differential Voltage		± Supply Voltage	V
VI	Input Common Mode Voltage Range (Note 1)		-0.2 V to (V _{DD} + 0.2 V)	V
l _l	Maximum Input Current		±10	mA
Ιο	Output Current Range		±100	mA
	Continuous Total Power Dissipation (Note 1)		200	mW
TJ	Maximum Junction Temperature		150	°C
T _A	Operating Ambient Temperature Range (free-air)		-40 to 125	°C
T _{STG}	Storage Temperature Range		-65 to 150	°C
ESD _{HBM}	ESD Capability, Human Body Model		2	kV
ESD _{CDM}	ESD Capability, Charged Device Model	TLV271 TLV/NCV272 TLV/NCV274	TBD 2 1	kV kV kV
	Mounting Temperature (Infrared or Convection – 20 sec)		260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL INFORMATION

Parameter	Symbol	Package	Single Layer Board (Note 2)	Multi–Layer Board (Note 3)	Unit
		TSOP-5	333	195	
		Micro-8 / MSOP-8	236	167	
Junction-to-Ambient	$\theta_{\sf JA}$	SOIC-8	190	131	°C/W
		SOIC-14	142	101	
		TSSOP-14	179	128	

^{2.} Values based on a 1S standard PCB according to JEDEC51-3 with 1.0 oz copper and a 300 mm² copper area

^{1.} Continuous short–circuit operation to ground at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Output currents in excess of 45 mA over long term may adversely affect reliability. Shorting output to either V+ or V- will adversely affect reliability.

^{3.} Values based on a 1S2P standard PCB according to JEDEC51-7 with 1.0 oz copper and a 100 mm² copper area

TLV271 DC ELECTRICAL CHARACTERISTICS

(V_{DD} = 2.7V, 3.3V, 5V & \pm 5 V (Note 4), T_A = 25°C, R_L \geq 10 k Ω unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
Input Offset Voltage	V _{IO}	$VIC = V_{DD}/2, V_{O} = V_{DD}/2, R_{L} = 10 \text{ k}\Omega, R_{S}$	S = 50 Ω		0.5	5	mV
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$				7	
Offset Voltage Drift	ICV _{OS}	VIC = $V_{DD}/2$, $V_O = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$, R_S	S = 50 Ω		2		μV/°C
Common Mode	CMRR	$0 \text{ V} \leq \text{VIC} \leq \text{V}_{DD} - 1.35 \text{ V}, \text{ R}_{S} = 50 \Omega$	V _{DD} = 2.7 V	58	70		dB
Rejection Ratio		T _A = -40°C to +105°C		55			
		$0 \text{ V} \leq \text{VIC} \leq \text{V}_{DD} - 1.35 \text{ V}, \text{ R}_{S} = 50 \Omega$	V _{DD} = 5 V	65	130		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		62			
		$0 \text{ V} \leq \text{VIC} \leq \text{V}_{DD} - 1.35 \text{ V}, \text{R}_{S} = 50 \Omega$	$V_{DD} = \pm 5 V$	69	140		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		66			
Power Supply	PSRR	V_{DD} = 2.7 V to 16 V, VIC = V_{DD} /2, No Load		70	135		dB
Rejection Ratio		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$					
Large Signal	A_{VD}	$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 2.7 V	97	106		dB
Voltage Gain		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		76			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 3.3 V	97	123		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		76			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 5 V	100	127		1
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		86			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	$V_{DD} = \pm 5 \text{ V}$	100	130		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		90			
Input Bias Current	Ι _Β	$V_{DD} = 5 \text{ V, VIC} = V_{DD}/2, V_{O} = V_{DD}/2,$	T _A = 25°C		45	150	pА
		$R_S = 50 \Omega$	T _A = 105°C			1000	
Input Offset Current	I _{IO}	$V_{DD} = 5 \text{ V, VIC} = V_{DD}/2, V_{O} = V_{DD}/2,$	T _A = 25°C		45	150	pА
		$R_S = 50 \Omega$	T _A = 105°C			1000	
Differential Input Resistance	r _{i(d)}				1000		GΩ
Common-mode Input Capacitance	C _{IC}	f = 21 kHz			8		pF

^{4.} $V_{DD} = \pm 5 \text{ V}$ is shorthand for $V_{DD} = +5 \text{ V}$ and $V_{EE} = -5 \text{ V}$.

TLV271 DC ELECTRICAL CHARACTERISTICS

(V_DD = 2.7V, 3.3V, 5V & $\pm\,5$ V (Note 4), T_A = 25°C, $R_L\,\geq\,10~k\Omega$ unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
Output Swing	V _{OH}	$VIC = V_{DD}/2$, $I_{OH} = -1$ mA	V _{DD} = 2.7 V	2.55	2.58		V
(High-level)		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		2.48			
		$VIC = V_{DD}/2$, $I_{OH} = -1$ mA	V _{DD} = 3.3 V	3.15	3.21		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		3.00			
		$VIC = V_{DD}/2$, $I_{OH} = -1$ mA	V _{DD} = 5 V	4.8	4.93		
		T _A = -40°C to +105°C		4.75			
		$VIC = V_{DD}/2$, $I_{OH} = -1$ mA	V _{DD} = ±5 V	4.92	4.96		
		T _A = -40°C to +105°C		4.9			
		$VIC = V_{DD}/2$, $I_{OH} = -5$ mA	V _{DD} = 2.7 V	1.9	2.1		V
		T _A = -40°C to +105°C		1.5			
		$VIC = V_{DD}/2$, $I_{OH} = -5$ mA	V _{DD} = 3.3 V	2.5	2.89		
		T _A = -40°C to +105°C		2.1			
		$VIC = V_{DD}/2$, $I_{OH} = -5$ mA	V _{DD} = 5 V	4.5	4.68		
		T _A = -40°C to +105°C		4.35			
		$VIC = V_{DD}/2$, $I_{OH} = -5$ mA	V _{DD} = ±5 V	4.7	4.78		1
		T _A = -40°C to +105°C		4.65			
Output Swing	V _{OL}	$VIC = V_{DD}/2$, $I_{OL} = -1$ mA	V _{DD} = 2.7 V		0.1	0.15	V
(Low-level)		T _A = -40°C to +105°C				0.22	
		$VIC = V_{DD}/2$, $I_{OL} = -1$ mA	V _{DD} = 3.3 V		0.03	0.15	
		T _A = -40°C to +105°C				0.22	
		$VIC = V_{DD}/2$, $I_{OL} = -1$ mA	V _{DD} = 5 V		0.03	0.1	
		T _A = -40°C to +105°C				0.15	
		$VIC = V_{DD}/2$, $I_{OL} = -1$ mA	V _{DD} = ±5 V		0.05	0.08	
		T _A = -40°C to +105°C				0.1	
		$VIC = V_{DD}/2$, $I_{OL} = -5$ mA	V _{DD} = 2.7 V		0.5	0.7	V
		T _A = -40°C to +105°C				1.1	
		$VIC = V_{DD}/2$, $I_{OL} = -5$ mA	V _{DD} = 3.3 V		0.13	0.7	
		T _A = -40°C to +105°C				1.1	
		$VIC = V_{DD}/2$, $I_{OL} = -5$ mA	V _{DD} = 5 V		0.13	0.4	
		T _A = -40°C to +105°C				0.5	
		$VIC = V_{DD}/2$, $I_{OL} = -5$ mA	V _{DD} = ±5 V		0.16	0.3	
		T _A = -40°C to +105°C				0.35	
Output Current	I _O	$V_O = 0.5 \text{ V from rail}, V_{DD} = 2.7 \text{ V}$	Positive rail		4.0		mA
			Negative rail		5.0		
		$V_O = 0.5 \text{ V from rail}, V_{DD} = 5 \text{ V}$	Positive rail		7.0		
			Negative rail		8.0		
		$V_O = 0.5 \text{ V from rail}, V_{DD} = 10 \text{ V}$	Positive rail		13		
			Negative rail		12		

^{4.} $V_{DD} = \pm 5 \text{ V}$ is shorthand for $V_{DD} = +5 \text{ V}$ and $V_{EE} = -5 \text{ V}$.

TLV271 DC ELECTRICAL CHARACTERISTICS

(V_DD = 2.7V, 3.3V, 5V & $\pm\,5$ V (Note 4), T_A = 25°C, R_L $\geq\,$ 10 k Ω unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
Power Supply Quiescent Current	I _{DD}	$V_O = V_{DD}/2$	V _{DD} = 2.7 V		380	560	μΑ
Quiescent Current			V _{DD} = 3.3 V		385	620	
			V _{DD} = 5 V		390	660	
			V _{DD} = 10 V		400	800	
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$				1000	

^{4.} $V_{DD} = \pm 5 \text{ V}$ is shorthand for $V_{DD} = +5 \text{ V}$ and $V_{EE} = -5 \text{ V}$.

TLV271 AC ELECTRICAL CHARACTERISTICS

(V_{DD} = 2.7 V, 5 V, & ± 5 V (Note 5), T_A = 25°C, and R_L \geq 10 k Ω unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
Unity Gain	UGBW	$R_L = 2 \text{ k}\Omega$, $C_L = 10 \text{ pF}$	V _{DD} = 2.7 V		3.2		MHz
Bandwidth		10 V	V _{DD} = 5 V to 10 V		3.5		
Slew Rate at Unity	SR	$V_{O(pp)} = V_{DD}/2, R_L = 10 \text{ k}\Omega, C_L = 50 \text{ pF}$	V _{DD} = 2.7 V	1.35	2.1		V/μS
Gain		T _A = -40°C to +105°C		1			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$, $C_L = 50 \text{ pF}$	V _{DD} = 5 V	1.45	2.3		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		1.2			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$, $C_L = 50 \text{ pF}$	$V_{DD} = \pm 5 V$	1.8	2.6		
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$		1.3			
Phase Margin	θ_{m}	$R_L = 2 \text{ k}\Omega$, $C_L = 10 \text{ pF}$			45		0
Gain Margin		$R_L = 2 \text{ k}\Omega$, $C_L = 10 \text{ pF}$			14		dB
Settling Time to 0.1%	t _S	$ \begin{array}{c} \text{V-step(pp)} = 1 \text{ V, AV} = -1, \text{ R}_L = 2 \text{ k}\Omega, \\ \text{C}_L = 10 \text{ pF} \end{array} $	V _{DD} = 2.7 V		2.9		μS
		V -step(pp) = 1 V, AV = -1, R_L = 2 k Ω , C_L = 47 pF	V _{DD} = 5 V, ± 5 V		2.0		
Total Harmonic	THD+N	$V_{DD} = 2.7 \text{ V}, V_{O(pp)} = V_{DD}/2, R_L = 2 \text{ k}\Omega,$	AV = 1		0.004		%
Distortion plus Noise		f = 10 kHz	AV = 10		0.04		
			AV = 100		0.3		
		$V_{DD} = 5 \text{ V}, \pm 5 \text{ V}, V_{O(pp)} = V_{DD}/2, R_L =$	AV = 1		0.004		
		2 kΩ, f = 10 kHz	AV = 10		0.04		
			AV = 100		0.03		
Input-Referred	e _n	f = 1 kHz			30		nV/√Hz
Voltage Noise		f = 10 kHz			20		
Input-Referred Current Noise	i _n	f = 1 kHz			0.6		fA/√Hz

^{5.} V_{DD} = ± 5 V is shorthand for V_{DD} = + 5 V and V_{EE} = - 5 V.

TLV/NCV 272/274 DC ELECTRICAL CHARACTERISTICS

((V_DD = 2.7 V, 5 V, 10 V, 36 V), T_A = 25°C, $R_L \geq~10~k\Omega$ unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
Input Offset Voltage	V _{IO}	VIC = $V_{DD}/2$, $V_O = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$			1.3	±3	mV
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				±4	
Offset Voltage Drift	ICV _{OS}	VIC = $V_{DD}/2$, $V_O = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$			2		μV/°C
Common Mode	CMRR	$V_{CM} = V_{SS} + 0.2 \text{ V to } V_{DD} - 1.35 \text{ V}$	V _{DD} = 2.7 V	90	110		dB
Rejection Ratio		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		69			
		$V_{CM} = V_{SS} + 0.2 \text{ V to } V_{DD} - 1.35 \text{ V}$	V _{DD} = 5 V	102	125		
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		80			
		V _{CM} = V _{SS} + 0.2 V to V _{DD} - 1.35 V	V _{DD} = 10 V	110	130		
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		87			
		V _{CM} = V _{SS} + 0.2 V to V _{DD} - 1.35 V	V _{DD} = 36 V	120	145		
		$T_A = -40^{\circ}\text{C to } + 125^{\circ}\text{C}$ (TLV/NCV272) (TLV/NCV274)		95 85			
Power Supply	PSRR	V_{DD} = 2.7 V to 36 V, VIC = $V_{DD}/2$, No Loa	ıd	114	135		dB
Rejection Ratio		T _A = -40°C to +125°C		100			
Large Signal	A _{VD}	$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 2.7 V	96	118		dB
Voltage Gain		T _A = -40°C to +125°C		86			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 5 V	96	120		
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		86			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 10 V	98	120		
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		88			
		$V_{O(pp)} = V_{DD}/2$, $R_L = 10 \text{ k}\Omega$	V _{DD} = 36 V	98	120		
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		88			
Input Bias Current	Ι _Β	$V_{DD} = 5 \text{ V}, \text{ VIC} = V_{DD}/2, V_{O} = V_{DD}/2$	T _A = 25°C		5	200	pA
		$V_{DD} = 2.7 \text{ to } 36 \text{ V},$	TLV/NCV272			2000	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$	TLV/NCV274			1500	
Input Offset Current	I _{IO}	V_{DD} = 5 V, VIC = $V_{DD}/2$, V_{O} = $V_{DD}/2$, R_{S} = 50 Ω	T _A = 25°C		2	75	pА
	$V_{DD} = 2.7 \text{ to } 36 \text{ V},$	V _{DD} = 2.7 to 36 V,	TLV/NCV272			500	-
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$	TLV/NCV274			200	
Channel Separation	XTLK	DC	TLV/NCV272		100		dB
			TLV/NCV274		115		dB
Differential Input Resistance	R _{i(d)}				5		GΩ
Common-mode Input Capacitance	C _{IC}				3.5		pF

TLV/NCV 272/274 DC ELECTRICAL CHARACTERISTICS

((V_DD = 2.7 V, 5 V, 10 V, 36 V), T_A = 25°C, $R_L \geq~10~k\Omega$ unless otherwise noted)

Parameter	Symbol	Condition	s	Min	Тур	Max	Unit
Output Swing	V _{OH}	VIC = V _{DD} /2	V _{DD} = 2.7 V		0.006	0.15	V
(High-level)		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.22	
		VIC = V _{DD} /2	V _{DD} = 5 V		0.013	0.20	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.25	
		VIC = V _{DD} /2	V _{DD} = 10 V		0.023	0.08	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.10	
		VIC = V _{DD} /2	V _{DD} = 36 V		0.074	0.10	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.15	
Output Swing	V _{OL}	VIC = V _{DD} /2	V _{DD} = 2.7 V		0.005	0.15	V
(Low-level)		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.22	
		VIC = V _{DD} /2	V _{DD} = 5 V		0.01	0.10	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.15	
		VIC = V _{DD} /2	V _{DD} = 10 V		0.022	0.3	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.35	
		VIC = V _{DD} /2	V _{DD} = 36 V		0.065	0.3	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$				0.35	
Output Current	Io	V _{DD} = 2.7 V	Positive rail		50		mA
			Negative rail		70		
		V _{DD} = 5 V	Positive rail		60		
			Negative rail		50		
		V _{DD} = 10 V	Positive rail		65		
			Negative rail		50		
		V _{DD} = 36 V	Positive rail		65		
			Negative rail		50		
Power Supply Quiescent Current	I _{DD}	V _O = V _{DD} /2, Per channel, no load	V _{DD} = 2.7 V		405	525	μΑ
Quiescent Current		rei chaillei, no load	V _{DD} = 5 V		410	530	
			V _{DD} = 10 V		416	540	
			V _{DD} = 36 V		465	600	
		$T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$				700	

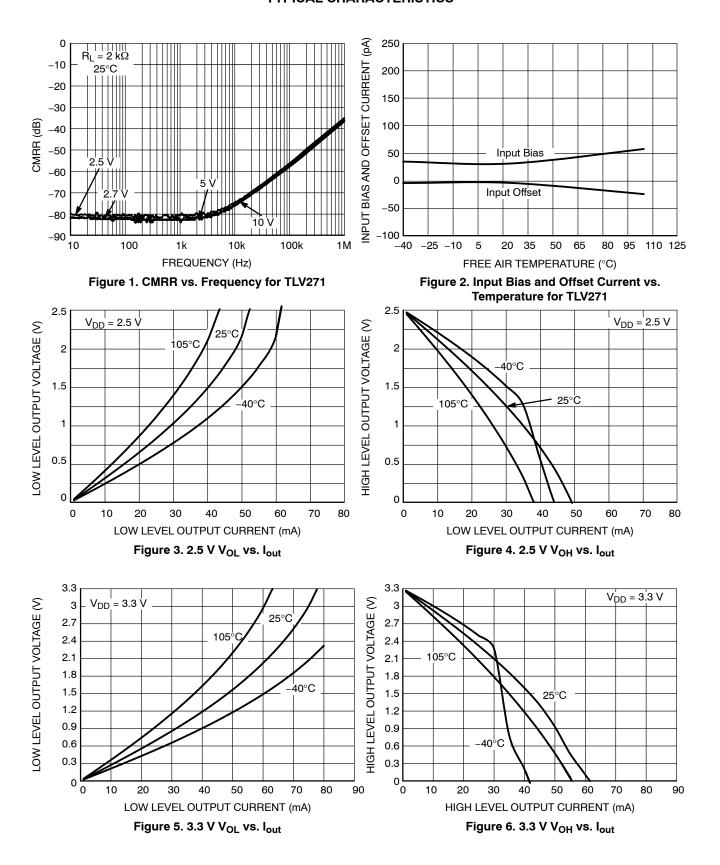
NOTE: Power dissipation must be limited to prevent junction temperature from exceeding 150°C. See Absolute Maximum Ratings for more information.

TLV/NCV 272/274 AC ELECTRICAL CHARACTERISTICS

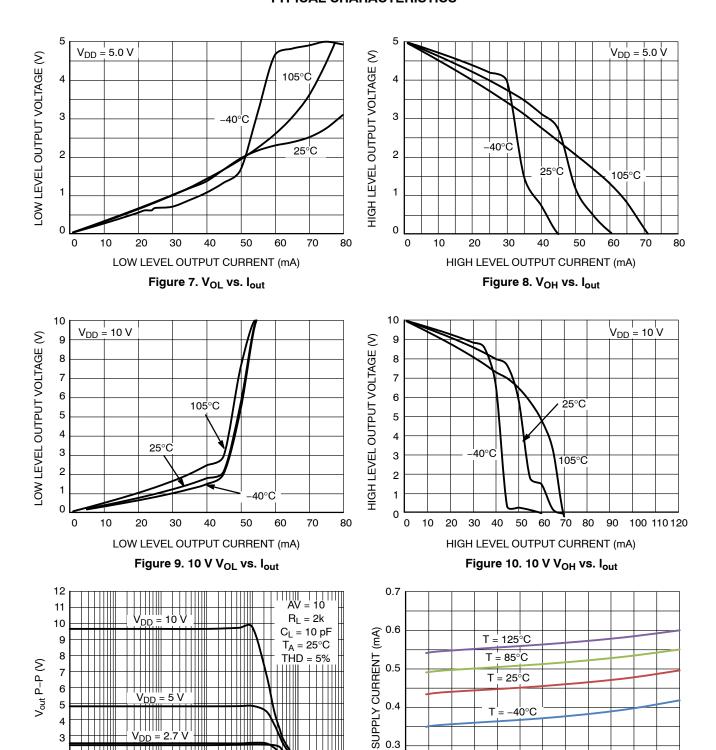
((V_DD = 2.7 V, 5 V, 10 V, 36 V), T_A = 25°C, and $R_L \geq$ 10 $k\Omega$ unless otherwise noted)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
Unity Gain Bandwidth	UGBW	C _L = 25 pF	V _{DD} = 2.7 V		3		MHz
Slew Rate at Unity	SR	C_L = 20 pF, R_L = 2 k Ω	V _{DD} = 2.7 V		2.8		V/μS
Gain			V _{DD} = 5 V		2.7		
			V _{DD} = 10 V		2.6		
			V _{DD} = 36 V		2.4		
Phase Margin	θ_{m}	C _L = 25 pF			50		٥
Gain Margin		C _L = 25 pF			14		dB
Settling Time to	t _S	$V_{O} = 1 V_{pp}$, Gain = 1, $C_{L} = 20 pF$	V _{DD} = 2.7 V		0.6		μS
0.1%		$V_{O} = 3 V_{pp}$, Gain = 1, $C_{L} = 20 pF$	V _{DD} = 5 V		1.2		
		V _O = 8.5 V _{pp} , Gain = 1, C _L = 20 pF	V _{DD} = 10 V		3.4		
		$V_O = 10 V_{pp}$, Gain = 1, $C_L = 20 pF$	V _{DD} = 36 V		3.2		
Total Harmonic	THD+N	$V_{IN} = 0.5 V_{pp}, f = 1 \text{ kHz}, Av = 1$	V _{DD} = 2.7 V		0.05		%
Distortion plus Noise		$V_{IN} = 2.5 V_{pp}, f = 1 \text{ kHz}, Av = 1$	V _{DD} = 5 V		0.009		
		$V_{IN} = 7.5 V_{pp}, f = 1 \text{ kHz}, Av = 1$	V _{DD} = 10 V		0.004		
		$V_{IN} = 28.5 V_{pp}, f = 1 \text{ kHz}, Av = 1$	V _{DD} = 36 V		0.001		
Input-Referred	e _n	f = 1 kHz	•		30		nV/√ Hz
Voltage Noise		f = 10 kHz			20		
Input-Referred Current Noise	i _n	f = 1 kHz			90		fA/√Hz

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



FREQUENCY (kHz)

Figure 11. Peak-to-Peak Output vs. Supply vs.

Frequency

10

100

1k

2

0.01

0.1

Figure 12. Quiescent Current Per Channel vs. Supply Voltage for TLV/NCV272/274

18

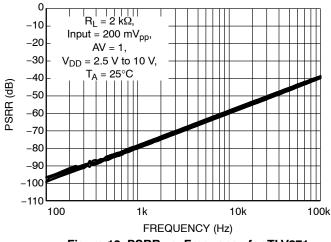
SUPPLY VOLTAGE (V)

36

10k

0.2

TYPICAL CHARACTERISTICS



140 $V_S = 2.7 \text{ V}, V_{SS}$ 120 $V_S = 36 \text{ V}, V_{DD}$ $V_S = 36 V V_{SS}$ 100 PSRR (dB) 80 60 40 20 0 10 100 1k 10k 100k 1M FREQUENCY (Hz)

Figure 13. PSRR vs. Frequency for TLV271

Figure 14. PSRR vs. Frequency for TLV/NCV272/274

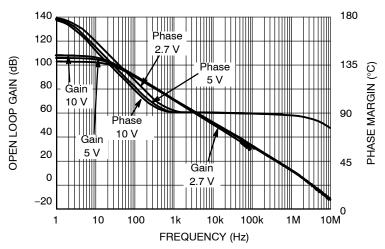


Figure 15. Open Loop Gain and Phase vs. Frequency

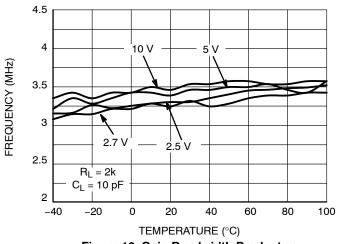


Figure 16. Gain Bandwidth Product vs.
Temperature

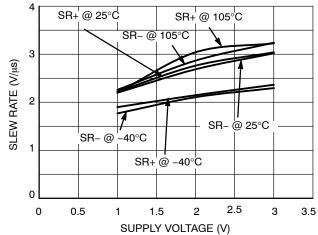


Figure 17. Slew Rate vs. Supply Voltage

TYPICAL CHARACTERISTICS

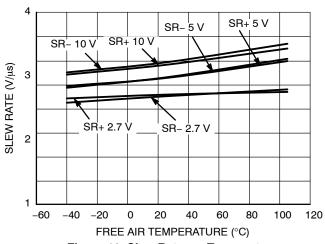


Figure 18. Slew Rate vs. Temperature

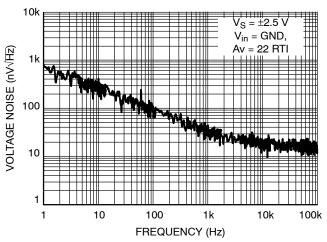


Figure 19. Voltage Noise vs. Frequency

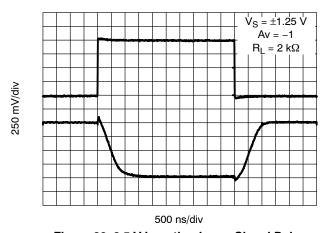


Figure 20. 2.5 V Inverting Large Signal Pulse Response

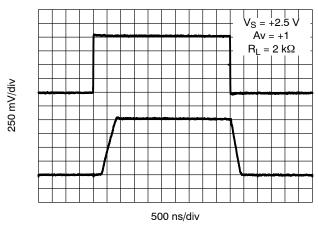


Figure 21. 2.5 V Non-Inverting Large Signal Pulse Response

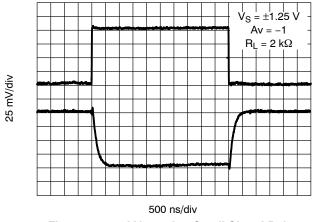


Figure 22. 2.5 V Inverting Small Signal Pulse Response

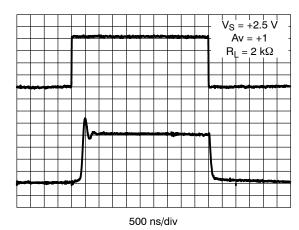


Figure 23. 2.5 V Non-Inverting Small Signal Pulse Response

25 mV/div

TYPICAL CHARACTERISTICS

250 mV/div

25 mV/div

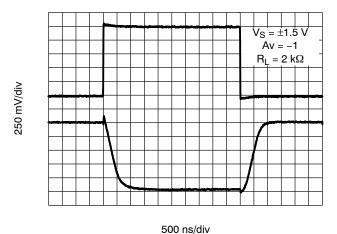


Figure 24. 3 V Inverting Large Signal Pulse Response

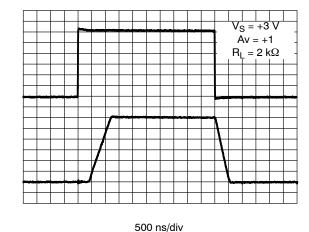


Figure 25. 3 V Non-Inverting Large Signal Pulse Response

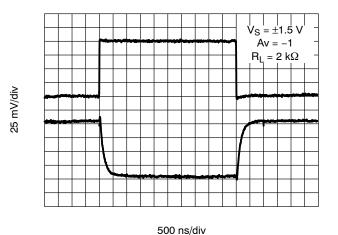


Figure 26. 3 V Inverting Small Signal Pulse Response

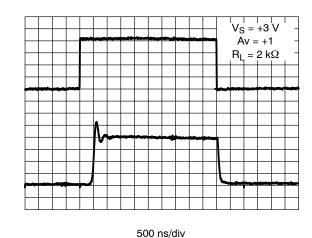


Figure 27. 3 V Non-Inverting Small Signal Pulse Response

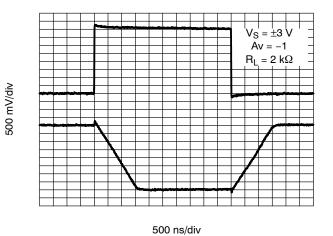


Figure 28. 6 V Inverting Large Signal Pulse Response

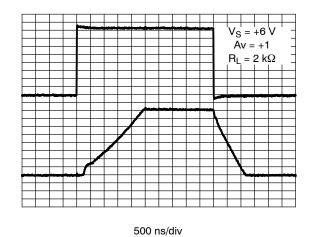


Figure 29. 6 V Non-Inverting Large Signal Pulse Response

500 mV/div

TYPICAL CHARACTERISTICS

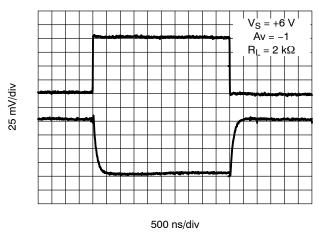


Figure 30. 6 V Inverting Small Signal Pulse Response

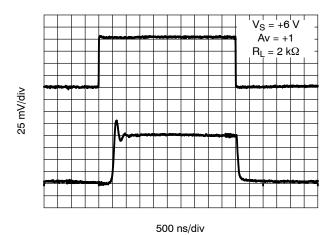


Figure 31. 6 V Non-Inverting Small Signal Pulse Response

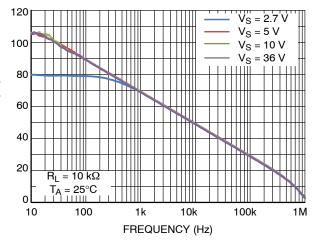


Figure 32. CMRR vs. Frequency for TLV/NCV272/274

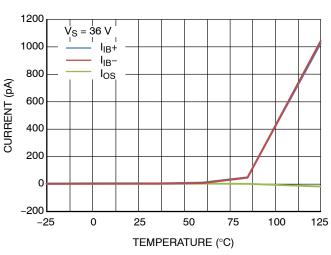


Figure 33. Input Bias and Offset Current vs. Temperature for TLV/NCV272/274

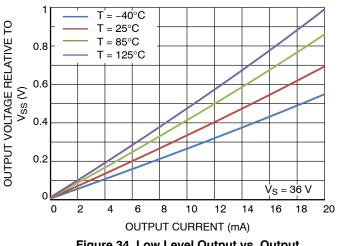


Figure 34. Low Level Output vs. Output Current for TLV/NCV272/274

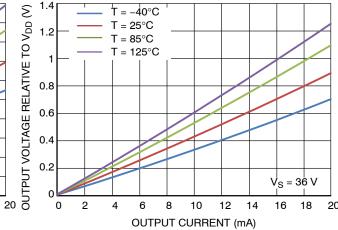


Figure 35. High Level Output vs. Output Current for TLV/NCV272/274

TYPICAL CHARACTERISTICS

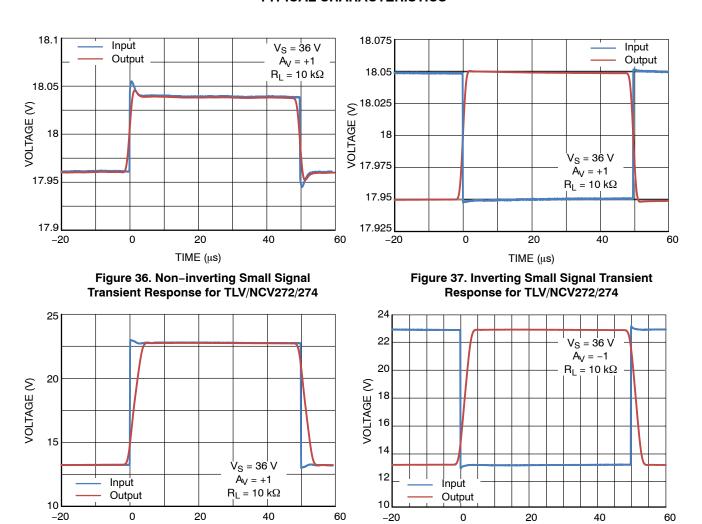


Figure 38. Non-inverting Large Signal Transient Response for TLV/NCV272/274

TIME (µs)

Figure 39. Inverting Large Signal Transient Response for TLV/NCV272/274

TIME (µs)

APPLICATIONS

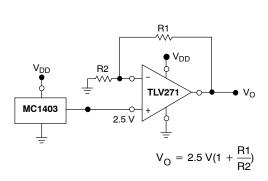


Figure 40. Voltage Reference

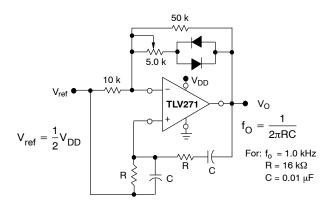


Figure 41. Wien Bridge Oscillator

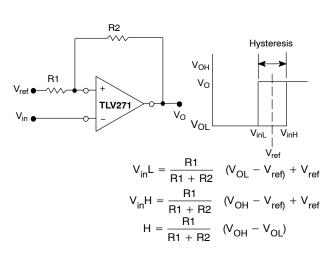
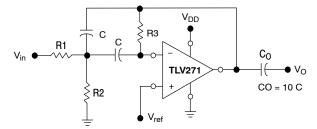


Figure 42. Comparator with Hysteresis



Given: f_0 = center frequency $A(f_0)$ = gain at center frequency

Choose value
$$f_o$$
, $\frac{C}{Q}$
Then: $R3 = \frac{R}{\pi f_O} \frac{C}{C}$
$$R1 = \frac{R3}{2 \, A(f_O)}$$

$$R2 = \frac{R1 \, R3}{4Q^2 \, R1 - R3}$$

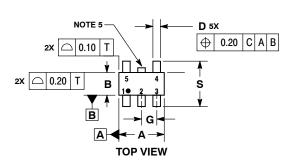
For less than 10% error from operational amplifier, (($Q_O f_O$)/BW) < 0.1 where f_o and BW are expressed in Hz. If source impedance varies, filter may be preceded with voltage follower buffer to stabilize filter parameters.

Figure 43. Multiple Feedback Bandpass Filter

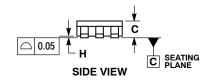


TSOP-5 **CASE 483 ISSUE N**

DATE 12 AUG 2020







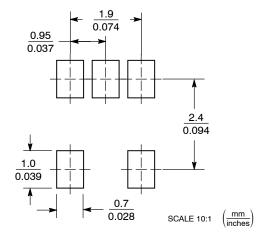


NOTES:

- DIMENSIONING AND TOLERANCING PER ASME
- CONTROLLING DIMENSION: MILLIMETERS.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH
 THICKNESS. MINIMUM LEAD THICKNESS IS THE
 MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSION A. OPTIONAL CONSTRUCTION: AN ADDITIONAL
- TRIMMED LEAD IS ALLOWED IN THIS LOCATION. TRIMMED LEAD NOT TO EXTEND MORE THAN 0.2 FROM BODY.

	MILLIMETERS					
DIM	MIN	MAX				
Α	2.85	3.15				
В	1.35	1.65				
C	0.90	1.10				
D	0.25	0.50				
G	0.95	BSC				
Н	0.01	0.10				
J	0.10	0.26				
K	0.20	0.60				
М	0 °	10 °				
S	2.50	3.00				

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*





XXX = Specific Device Code XXX = Specific Device Code

= Assembly Location

= Date Code = Year = Pb-Free Package

= Work Week W

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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SOIC-8 NB CASE 751-07 **ISSUE AK**

DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
C	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
Н	0.10	0.25	0.004	0.010
7	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
М	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot

= Year = Work Week

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww

= Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1 STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. PINS 2	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1 STYLE 7: PIN 1. IMPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2	3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE 2. SOURCE
PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND	PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2	PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE 2. SOURCE
PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND	PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2	PIN 1. SOURCE 2. SOURCE
6. BIAS 2 7. INPUT 8. GROUND	5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE
STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		
	PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN 8. N-DRAIN 8. N-DRAIN 8. N-DRAIN 8. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE 8. CATHODE 8. CATHODE 8. CATHODE 9. COMMON CATHODE/VCC 9. COMMON CATHODE/VCC 1. (/O LINE 1 2. COMMON CATHODE/VCC 1. (/O LINE 3 5. COMMON ANODE/GND 6. (/O LINE 5 8. COMMON ANODE/GND 8.	PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN 8. N-DRAIN 8. N-DRAIN 8. N-DRAIN 8. CATHODE, COMMON 8. N-DRAIN 7. CATHODE, COMMON 8. CATHODE 9IN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 4. GATE 2 5. DRAIN 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1 8. CATHODE 8. CATHODE 8. MIRROR 1 9IN 1. LINE 1 IN 2. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 8. LINE 1 OUT STYLE 26: PIN 1. GND 1. LINE 1 OUT STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 6. SOURCE 7. SOURCE 8. VCC STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2

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SOIC-14 NB CASE 751A-03 ISSUE L

DATE 03 FEB 2016









0.25 0.50 0.010 0.019 0.40 1.25 0.016 0.049

NOTES:
1. DIMENSIONING AND TOLERANCING PER

5. MAXIMUM MOLD PROTRUSION 0.15 PER

INCHES

MIN MAX

0.050 BSC

0.25 0.004 0.010

0.25 0.008 0.010

0.49 0.014

8.75 0.337 3.80 4.00 0.150 0.157

0.068

0.019

MILLIMETERS

MIN MAX

1.27 BSC

0.19

8.55

SIDE

Α

A1 0.10

АЗ

b 0.35

D E

e H h

ASME Y14.5M, 1994.
CONTROLLING DIMENSION: MILLIMETERS. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF AT MAXIMUM MATERIAL CONDITION.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSIONS.



GENERIC

XXXXX = Specific Device Code Α = Assembly Location

WL = Wafer Lot Υ = Year = Work Week WW G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator. "G" or microdot " ■". may or may not be present.

SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

STYLES ON PAGE 2

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^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

SOIC-14 CASE 751A-03 ISSUE L

DATE 03 FEB 2016

STYLE 1: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. NO CONNECTION 5. ANODE/CATHODE 6. NO CONNECTION 7. ANODE/CATHODE 8. ANODE/CATHODE 9. ANODE/CATHODE 10. NO CONNECTION 11. ANODE/CATHODE 12. ANODE/CATHODE 13. NO CONNECTION 14. COMMON ANODE	STYLE 2: CANCELLED	STYLE 3: PIN 1. NO CONNECTION 2. ANODE 3. ANODE 4. NO CONNECTION 5. ANODE 6. NO CONNECTION 7. ANODE 8. ANODE 9. ANODE 10. NO CONNECTION 11. ANODE 12. ANODE 13. NO CONNECTION 14. COMMON CATHODE	STYLE 4: PIN 1. NO CONNECTION 2. CATHODE 3. CATHODE 4. NO CONNECTION 5. CATHODE 6. NO CONNECTION 7. CATHODE 8. CATHODE 9. CATHODE 10. NO CONNECTION 11. CATHODE 12. CATHODE 13. NO CONNECTION 14. COMMON ANODE
STYLE 5: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. ANODE/CATHODE 5. ANODE/CATHODE 6. NO CONNECTION 7. COMMON ANODE 8. COMMON CATHODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. ANODE/CATHODE 12. ANODE/CATHODE 13. NO CONNECTION 14. COMMON ANODE	STYLE 6: PIN 1. CATHODE 2. CATHODE 3. CATHODE 4. CATHODE 5. CATHODE 6. CATHODE 7. CATHODE 8. ANODE 9. ANODE 10. ANODE 11. ANODE 12. ANODE 13. ANODE 14. ANODE	STYLE 7: PIN 1. ANODE/CATHODE 2. COMMON ANODE 3. COMMON CATHODE 4. ANODE/CATHODE 5. ANODE/CATHODE 6. ANODE/CATHODE 7. ANODE/CATHODE 8. ANODE/CATHODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. COMMON CATHODE 12. COMMON ANODE 13. ANODE/CATHODE 14. ANODE/CATHODE	STYLE 8: PIN 1. COMMON CATHODE 2. ANODE/CATHODE 3. ANODE/CATHODE 4. NO CONNECTION 5. ANODE/CATHODE 6. ANODE/CATHODE 7. COMMON ANODE 8. COMMON ANODE 9. ANODE/CATHODE 10. ANODE/CATHODE 11. NO CONNECTION 12. ANODE/CATHODE 13. ANODE/CATHODE 14. COMMON CATHODE

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Micro8 CASE 846A-02 ISSUE K

DATE 16 JUL 2020







NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.10 mm IN EXCESS OF MAXIMUM MATERIAL CONDITION.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER SIDE. DIMENSION E DDES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE. DIMENSIONS D AND E ARE DETERMINED AT DATUM F.
- DATUMS A AND B ARE TO BE DETERMINED AT DATUM F.
- A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



RECOMMENDED MOUNTING FOOTPRINT

MID	MI	LLIMETE	RS
DIM	MIN.	N□M.	MAX.
Α	-	-	1.10
A1	0.05	0.08	0.15
b	0.25	0.33	0.40
С	0.13	0.18	0.23
D	2.90	3.00	3.10
E	2.90	3.00	3.10
e	0.65 BSC		
HE	4.75	4.90	5.05
L	0.40	0.55	0.70

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code Α = Assembly Location

Υ = Year W = Work Week = Pb-Free Package

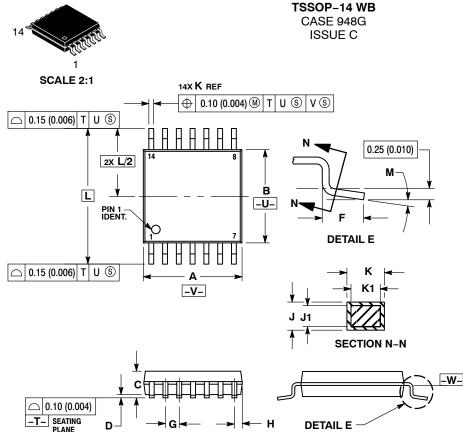
(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLE 1:	STYLE 2:	STYLE 3:
PIN 1. SOURCE	PIN 1. SOURCE 1	PIN 1. N-SOURCE
SOURCE	2. GATE 1	2. N-GATE
SOURCE	3. SOURCE 2	P-SOURCE
GATE	4. GATE 2	4. P-GATE
DRAIN	5. DRAIN 2	5. P-DRAIN
DRAIN	6. DRAIN 2	6. P-DRAIN
7. DRAIN	7. DRAIN 1	7. N-DRAIN
8. DRAIN	8. DRAIN 1	8. N-DRAIN

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DATE 17 FEB 2016

- NOTES.

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: MILLIMETER.

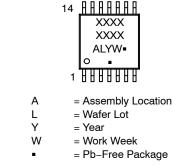
 3. DIMENSION A DOES NOT INCLUDE MOLD
- FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 DIMENSION B DOES NOT INCLUDE
- INTERLEAD FLASH OR PROTRUSION.
 INTERLEAD FLASH OR PROTRUSION SHALL
- INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.

 5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.

 6. TERMINAL NUMBERS ARE SHOWN FOR DEFERENCE ONLY.
- REFERENCE ONLY.
 DIMENSION A AND B ARE TO BE
 DETERMINED AT DATUM PLANE -W-.

	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.10	0.193	0.200
В	4.30	4.50	0.169	0.177
С	-	1.20		0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65	BSC	0.026	BSC
Н	0.50	0.60	0.020	0.024
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
K	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40		0.252	
М	° o	8 °	0 °	8 °

GENERIC MARKING DIAGRAM*



(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

◀	7.06
1	
	0.65
, <u> </u>	— — — • • • • • • • • • • • • • • • • • • •
0.36 14X 1.26	─
	DIMENSIONS: MILLIMETERS

SOLDERING FOOTPRINT

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